

High-d (Heidi) Swiss Army Knife

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Outline

James Gilmer: High-d Error Rates

Eric Nalisnick: Degenerate OOD detection in High-d

vd Oord and Theis: How Likelihoods Can Break in High-d

Charu Aggarwal: High-d Metric Surprises



James Gilmer: High-d Error Rates



James Gilmer: High-d Error Rates

Setup¹

- ▶ **error set** E : set of points in the input space on which the classifier makes an incorrect prediction
- ▶ **corruption robustness** $\mathbb{P}_{x \sim q}[x \notin E]$: probability that a random sample from the q is not an error, under a given corrupted image distribution q .
- ▶ **adversarial robustness** $\mathbb{P}_{x \sim p}[d(x, E) > \epsilon]$: probability that a random sample from p is not within distance ϵ of some point in the error set, where metric on the input space $d(x, E)$ denotes the distance from clean input x to the nearest point in E (also based on work by [2])
- ▶ **error rate** μ : $\mathbb{E}_{x \sim \mathcal{N}(x_0; \sigma^2 I)}[x \in E]$, with some clean image x_0 and the Gaussian distribution $\mathcal{N}(x_0; \sigma^2 I)$
- ▶ $\sigma(x_0, \mu)$: For a fixed μ , the σ for which the error rate is μ

¹<https://slideslive.com/38930579/>



James Gilmer: High-d Error Rates (cont'd)

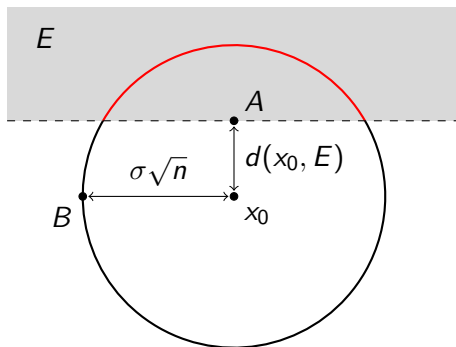


Figure 1: Sphere cutting illustration by [3]



James Gilmer: High-d Error Rates (cont'd)

Analysis

Letting d denote l_2 distance, we have

$$d(x_0, E) = -\sigma(x_0, \mu)\Phi^{-1}(\mu), \quad (1)$$

where

$$\Phi(t) = \frac{1}{\sqrt{2\pi}} \int_{-\infty}^t \exp(-x^2/2) dx$$

is the cdf of the univariate standard normal distribution. (Note that $\Phi^{-1}(\mu)$ is negative when $\mu < \frac{1}{2}$.)



James Gilmer: High-d Error Rates (cont'd)

Observations

- ▶ Equation 1 does not depend on n

n	$\sigma\sqrt{n}$	$d(x_0, E)$
3	0.17	0.23
150,528 (ImageNet)	38.8	0.23

Table 1: Linear model - distance of typical corrupted input ($\sigma\sqrt{n}$) and distance of nearest error ($d(x_0, E)$) under varying input dimension n

- ▶ $\frac{d(x_0, E)}{\sigma\sqrt{n}}$



James Gilmer: High-d Error Rates (cont'd)

Geometric Interpretation of Equation 1: Gaussian Annulus Theorem

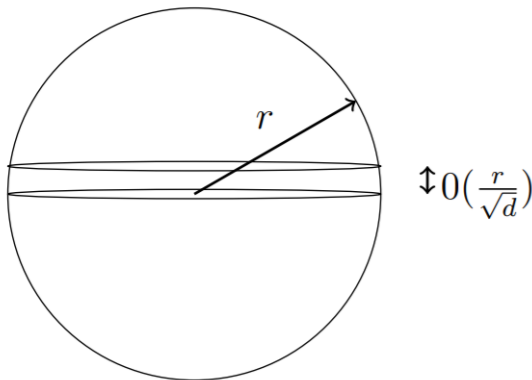


Figure 2: Equator concentration of spherical volume and surface area ²

²<https://www.cs.cmu.edu/~venkatg/teaching/CStheory-infoage/>



Eric Nalisnick: Degenerate OOD detection in High-d



Eric Nalisnick: Degenerate OOD detection in High-d

Decision rule:

$$p(\mathbf{X}^* | \text{IN}) > \frac{p(\mathbf{X}^* | \text{OUT}) p(\text{OUT})}{p(\text{IN})}$$

(a)

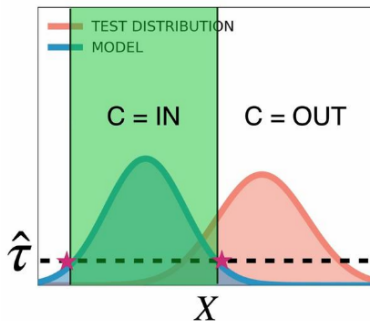
Decision rule:

$$\text{DGM } q(\mathbf{X}^*) > \underbrace{\frac{\text{UNIFORM}(\mathbf{X}^*) p(\text{OUT})}{p(\text{IN})}}_{\hat{\tau}}$$

Implies classifier is just a threshold on the density function:

$$q(\mathbf{X}^*) > \hat{\tau}$$

(b)



(c)



Eric Nalisnick: Degenerate OOD detection in High-d (cont'd)

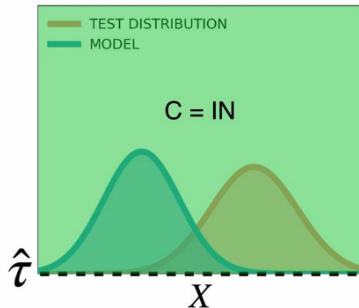
PROBLEM: In high-dimensions, the uniform OOD model becomes degenerate.

$$\text{UNIFORM}(\mathbf{x}) = \frac{1}{(b-a)^D} \rightarrow 0 \quad \text{as } D \rightarrow \infty$$

Which leads to the degenerate threshold:

$$q(\mathbf{X}^*) > \text{UNIFORM}(\mathbf{X}^*) \frac{p(\text{OUT})}{p(\text{IN})} = 0$$

(d)



(e)

Note: All visualizations by Eric Nalisnick, check his talk at <https://icml.cc/virtual/2020/workshop/5742>

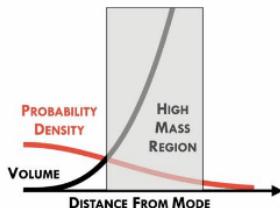


Eric Nalisnick: Degenerate OOD detection in High-d (cont'd)

Bonus Heidi

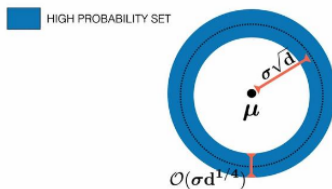
$$m = V \times \rho$$

In high dimensions, probability mass concentrates *away* from the mode.



(f)

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HIGH DIMENSIONAL GAUSSIAN

(g)



vd Oord and Theis: How Likelihoods Can Break in High-d



vd Oord and Theis: How Likelihoods Can Break in High-d

[4, 5]

Great log-likelihood and poor samples

- ▶ p : density of a model for d dimensional data \mathbf{x} which performs arbitrarily well with respect to average log-likelihood
- ▶ q : corresponds to some bad model (e.g., white noise)
- ▶ Then samples generated by the mixture model $0.01p(\mathbf{x}) + 0.99q(\mathbf{x})$ will come from the poor model 99% of the time
- ▶ Yet the log-likelihood per pixel will hardly change if d is large:
$$\log [0.01p(\mathbf{x}) + 0.99q(\mathbf{x})] \geq \log [0.01p(\mathbf{x})] = \log p(\mathbf{x}) - \log 100$$

For high-dimensional data, $\log p(\mathbf{x})$ will be proportional to d while $\log 100$ stays constant.







Charu Aggarwal: High-d Metric Surprises



[1] <https://bib.dbvis.de/uploadedFiles/155.pdf>



References I

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-  Justin Gilmer et al. “Adversarial examples are a natural consequence of test error in noise”. In: *International Conference on Machine Learning*. 2019, pp. 2280–2289.
-  Aäron van den Oord and Joni Dambre. “Locally-connected transformations for deep gmms”. In: *International Conference on Machine Learning (ICML): Deep learning Workshop*. 2015, pp. 1–8.



References II



Lucas Theis, Aäron van den Oord, and Matthias Bethge. “A note on the evaluation of generative models”. In: *arXiv preprint arXiv:1511.01844* (2015).

